## Search Notes



App	licatio	n/Co	ntrol	No
-----	---------	------	-------	----

10656846

Applicant(s)/Patent Under Reexamination

CHU ET AL.

Examiner SIMON KE Art Unit 2174

## SEARCHED

Class	Subclass	Date	Examiner
715	780, 781	1/22/08	PK
715	780, 781	7/6/08	PK
715	780, 781, 501, 513, 84-843, 790, 797, 853-855 and 760	1/4/09	PK
715	780, 781, 501, 513, 84-843, 790, 797, 853-855 and 760	7/17/09	PK
715	780, 781, 501, 513, 84-843, 790, 797, 853-855 and 760	12/14/09	PK
715	780, 781, 501, 513, 84-843, 790, 797, 853-855 and 760	6/19/10	PK

## SEARCH NOTES

CEARON NOTES				
Search Notes	Date	Examiner		
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT; USPUB; EPO; JPO; DERWENT)	1/22/08	PK		
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT; USPUB; EPO; JPO; DERWENT)	7/6/08	PK		
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT; USPUB; EPO; JPO; DERWENT)	1/4/09	PK		
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT; USPUB; EPO; JPO; DERWENT)	7/17/09	PK		
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT; USPUB; EPO; JPO; DERWENT)	12/14/09	PK		
East Text Search (715/501, 513, 84-843, 790, 797, 781, 853-855 and 760 USPAT; USPUB; EPO; JPO; DERWENT)	6/19/10	PK		

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner